

Search Notes

Application/Control No.

10/023,824

Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

KWANG-EUN AHN

Art Unit

2634

SEARCHED

Class	Subclass	Date	Examiner
330	149	2/10/2005	EMF
375	285	2/10/2005	EMF
375	296	2/10/2005	EMF
375	297	2/10/2005	EMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	2/9/2005	EMF
PALM INVENTORSHIP	2/9/2005	EMF